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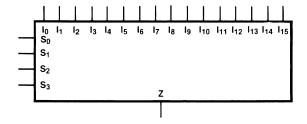
100364 Low Power 16-Input Multiplexer

Check for Samples: 100364

FEATURES

- 35% Power Reduction of the 100164
- 2000V ESD Protection
- Pin/function Compatible with 100164
- Voltage Compensated Operating Range = -4.2V to -5.7V
- Available to Industrial Grade Temperature Range
- Standard Microcircuit Drawing
 - (SMD) 5962-9459201

Logic Symbol



DESCRIPTION

The 100364 is a 16-input multiplexer. Data paths are controlled by four Select lines (S_0 – S_3). Their decoding is shown in Truth Table. Output data polarity is the same as the selected input data. All inputs have 50 k Ω pulldown resistors.

Table 1. PIN DESCRIPTIONS

Pin Names	Description
I ₀ -I ₁₅	Data Inputs
S ₀ -S ₃	Select Inputs
Z	Data Output

Connection Diagrams

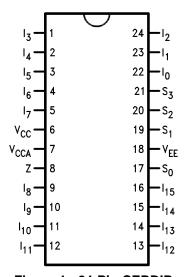


Figure 1. 24-Pin CERDIP

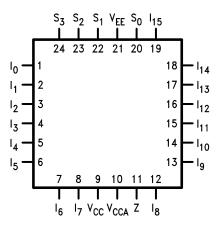


Figure 2. 24-Pin CPGA See NAQ0024C Package

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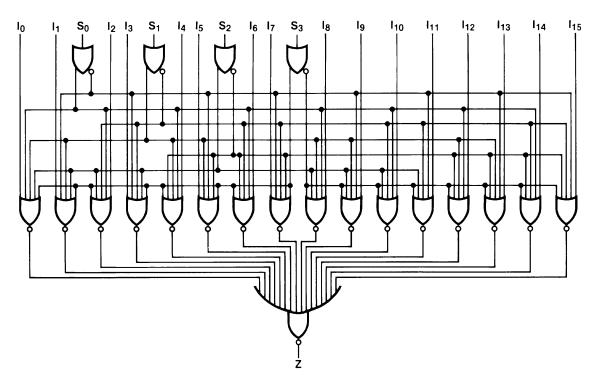


Figure 3. Logic Diagram

TRUTH TABLE(1)

	Select Inputs								
S ₀	S ₁	S ₂	S ₃	Z					
L H L H	L L H	L L L	L L L	l ₀ l ₁ l ₂ l ₃					
L H L H	L H H	IIII	L L L	₄ ₅ ₆ ₇					
L H L H	L L H	L L L	H H H	I ₈ I ₉ I ₁₀ I ₁₁					
L H L H	L L H	H H H	H H H	I ₁₂ I ₁₃ I ₁₄ I ₁₅					

(1) H = HIGH Voltage Level L = LOW Voltage Level

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ABSOLUTE MAXIMUM RATINGS (1)(2)

Above which the useful life may be impaired

Storage Temperature (T _{STG})	−65°C to +150°C	
Maximum Junction Temperature (T _J)	+175°C	
Pin Potential to Ground Pin (V _{EE})	−7.0V to +0.5V	
Input Voltage (DC)	V _{EE} to +0.5V	
Output Current	−50 mA	
ESD (3)	•	≥ 2000V

- (1) Absolute Maximum Ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
- (3) ESD testing conforms to MIL-STD-883, Method 3015.

RECOMMENDED OPERATING CONDITIONS

Case Temperature (T _C)	Military	−55°C to +125°C
Supply Voltage (V _{EE})	•	−5.7V to −4.2V

DC ELECTRICAL CHARACTERISTICS - MILITARY VERSION

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$, $T_{C} = -55^{\circ}C$ to +125°C

Symbol	Parameter	Min	Max	Units	T _C	Cond	ditions	Notes
V _{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to +125°C	$V_{IN} = V_{IH} (Max)$ or $V_{IL} (Min)$	Loading with 50Ω to -2.0V	See (1)(2)(3)
		-1085	-870	mV	−55°C			
V _{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to +125°C			
		-1830	-1555	mV	−55°C			
V _{OHC}	Output HIGH Voltage	-1035		mV	0°C to +125°C	$V_{IN} = V_{IH} \text{ (Min)}$ or $V_{IL} \text{ (Max)}$	Loading with 50Ω to -2.0V	See (1)(2)(3)
		-1085		mV	-55°C			
V _{OLC}	Output LOW Voltage		-1610	mV	0°C to +125°C			
			-1555	mV	−55°C			
V _{IH}	Input HIGH Voltage	-1165	-870	mV	−55°C to +125°C	Ensured HIGH Sig for All Inputs	ınal	See (1)(2)(3)(4)
V _{IL}	Input LOW Voltage	-1830	-1475	mV	-55°C to +125°C	Ensured LOW Signature for All Inputs	nal	See (1)(2)(3)(4)
I _{IL}	Input LOW Current	0.50		μΑ	−55°C to +125°C	$V_{EE} = -4.2V$ $V_{IN} = V_{IL}$ (Min)		See (1)(2)(3)
I _{IH}	Input HIGH Current		300	μΑ	0°C to +125°C	$V_{EE} = -5.7V$ $V_{IN} = V_{IH} (Max)$		See (1)(2)(3)
			450	μΑ	−55°C			
I _{EE}	Power Supply Current	-95	-35	mA	-55°C to +125°C	Inputs Open		See (1)(2)(3)

⁽¹⁾ F100K 300 Series cold temperature testing is performed by temperature soaking (to ensure junction temperature equals −55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

(4) Ensured by applying specified input condition and testing V_{OH}/V_{OL}.

Product Folder Links: 100364

⁽²⁾ Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups, 1, 2, 3, 7 and 8.

⁽³⁾ Sampled tested (Method 5005, Table I) on each manufactured lot at −55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7 and 8.



AC ELECTRICAL CHARACTERISTICS

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	T _C = -	-55°C	$T_C = 25^{\circ}C$		$T_C = 25^{\circ}C$ $T_C = +125^{\circ}C$		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t _{PLH} t _{PHL}			2.60	0.60	2.40	0.60	2.80	ns	See Figure 4 and Figure 5	See (1)(2)(3)
t _{PLH} t _{PHL}	Propagation Delay S ₀ , S ₁ to Output	0.70	3.30	0.90	3.10	1.00	3.50	ns		
t _{PLH} t _{PHL}	Propagation Delay S ₂ , S ₃ to Output	0.50	2.90	0.70	2.60	0.60	3.00	ns		
t _{TLH} t _{THL}	Transition Time 20% to 80%, 80% to 20%	0.20	1.20	0.20	1.20	0.20	1.20	ns		See (4)

- F100K 300 Series cold temperature testing is performed by temperature soaking (to ensure junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.
- Screen tested 100% on each device at +25°C, temperature only, Subgroup A9.

 Sample tested (Method 5005, Table I) on each Mfg. lot at +25°C, Subgroup A9, and at +125°C, and -55°C temp., Subgroups A10 and A11.
- Not tested at +25°C, +125°C and -55°C temperature (design characterization data).

TEST CIRCUIT

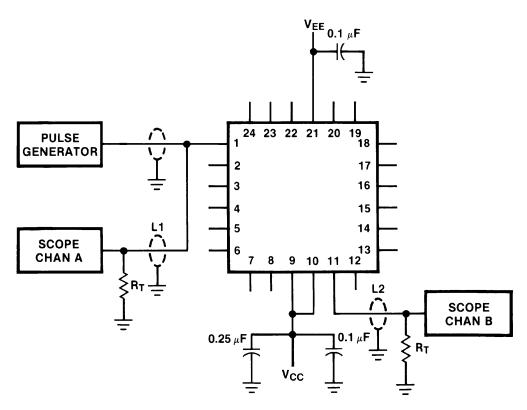
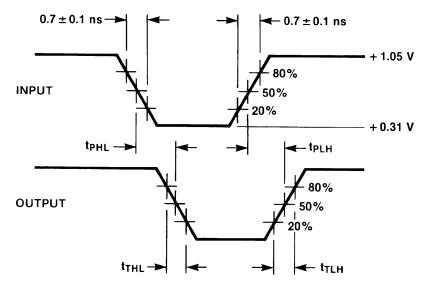


Figure 4. AC Test Circuit

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Switching Waveforms



 V_{CC} , $V_{CCA} = +2V$, $V_{EE} = -2.5V$

L1 and L2 = Equal length 50Ω impedance lines

 $R_T = 50\Omega$ terminator internal to scope

Decoupling 0.1 μF from GND to V_{CC} and V_{EE}

All unused outputs are loaded with $50\Omega\ to\ GND$

 C_L = Fixture and stray capacitance \leq 3 pF

Pin numbers shown are for flatpak; for DIP see logic symbol

Figure 5. Propagation Delay and Transition Times

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REVISION HISTORY

Cł	hanges from Revision A (April 2013) to Revision B	Page
•	Changed layout of National Data Sheet to TI format	

Product Folder Links: 100364

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